

COMPLIANT

HALOGEN FREE

HM4886E-VB Datasheet

Dual N-Channel 100-V (D-S) MOSFET

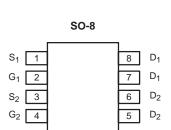
PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)			
100	0.063 at V _{GS} = 10 V	5.8	9 nC			
100	0.084 at V _{GS} = 6 V	4.8	9110			

FEATURES

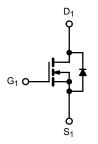
- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET
- 100 % UIS Tested

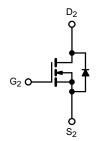
APPLICATIONS

- High Frequency Boost Converter
- LED Backlight for LCD TV



Top View





N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN Parameter	Α ,	Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	100	
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		5.8	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	I_	4.4	
Continuous Brain Current (1) = 150 °C)	T _A = 25 °C	ID	3.4 ^{a, b}	
	T _A = 70 °C	1	2.5 ^{a, b}	A
Pulsed Drain Current		I _{DM}	20	^
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	5	
Continuous Source-Drain Diode Current	T _A = 25 °C	'5	2.1 ^{a, b}	
Single Avalanche Current	L = 0.1 mH	I _{AS}	19	
Single Avalanche Energy		E _{AS}	18	mJ
	T _C = 25 °C	P _D	5	
Maximum Power Dissipation	T _C = 70 °C		3.2	w
waximum rower Dissipation	T _A = 25 °C		2.5 ^{a, b}	
	T _A = 70 °C		1.6 ^{a, b}	
Operating Junction and Storage Temperature	e Range	T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, c}	t ≤ 10 s	R_{thJA}	37	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	17	21	0/ * *		

Notes

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under Steady State conditions is 85 °C/W.
- d. $T_C = 25$ °C.

服务热线:400-655-8788

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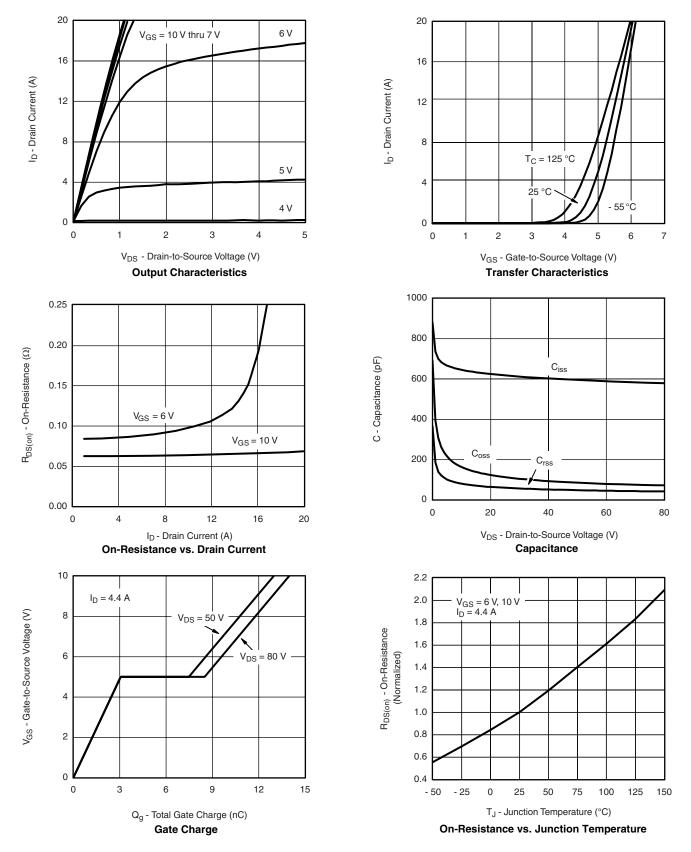
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						1	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		120		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 9			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		4.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0 1 1/1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	1	V _{DS} = 100 V, V _{GS} = 0 V			1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	20			Α	
		V _{GS} = 10 V, I _D = 3.4 A	0.063				
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 6 \text{ V}, I_D = 2.8 \text{ A}$		0.084		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 3.4 A		10		S	
Dynamic ^b						1	
Input Capacitance	C _{iss}			600			
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		90		pF	
Reverse Transfer Capacitance	C _{rss}			50			
	Q _g	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 3.4 \text{ A}$		13.5	20		
Total Gate Charge				9	13.5	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 3.4 \text{ A}$		3			
Gate-Drain Charge	Q_{gd}			4.6			
Gate Resistance	R_{g}	f = 1 MHz		1		Ω	
Turn-On Delay Time	t _{d(on)}			15	25	ns	
Rise Time	t _r	V_{DD} = 50 V, R_L = 14.3 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 3.5$ A, $V_{GEN}=6$ V, $R_g=1$ Ω		12	20		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	V_{DD} = 50 V, R_L = 14.3 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 3.5$ A, V_{GEN} = 10 V, R_g = 1 Ω		15	25		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			5	۸	
Pulse Diode Forward Current	I _{SM}				20	_ A	
Body Diode Voltage	V_{SD}	$I_S = 3.5 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			45	70	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 2.5.4 dl/dt = 100.4/ T = 05.90		80	120	nC	
Reverse Recovery Fall Time	ta	$I_F = 3.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		33			
Reverse Recovery Rise Time		t _b		12		ns	

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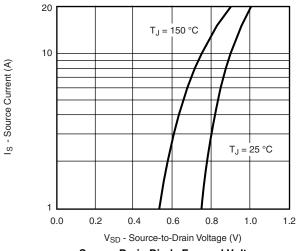
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

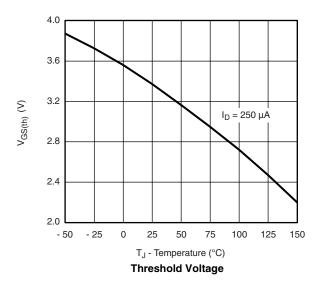


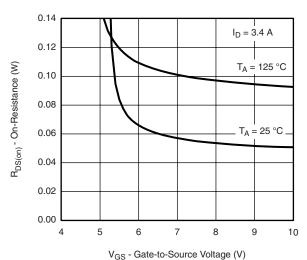




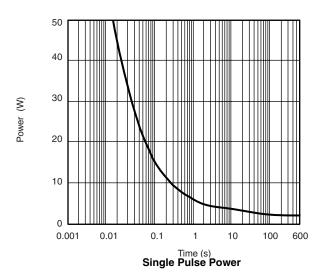


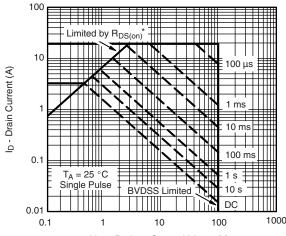
Source-Drain Diode Forward Voltage





On-Resistance vs. Gate-to-Source Voltage

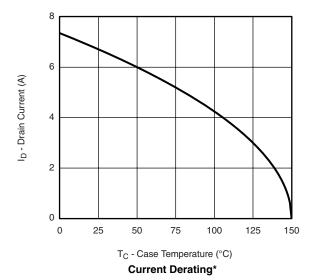


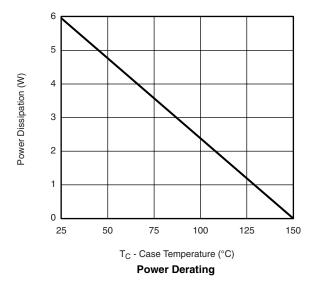


 $\label{eq:VDS} V_{DS} \text{ - Drain-to-Source Voltage (V)} $$^*V_{GS} > $$ minimum V_{GS}$ at which $R_{DS(on)}$ is specified$

Safe Operating Area, Junction-to-Ambient

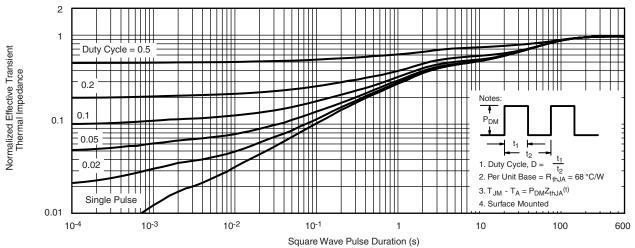




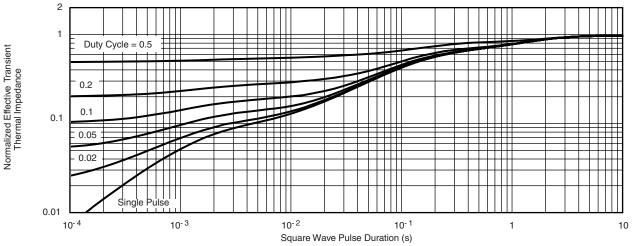


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





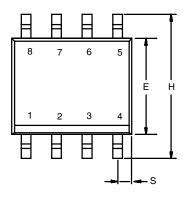
Normalized Thermal Transient Impedance, Junction-to-Ambient

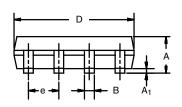


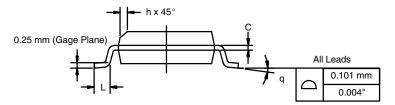
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







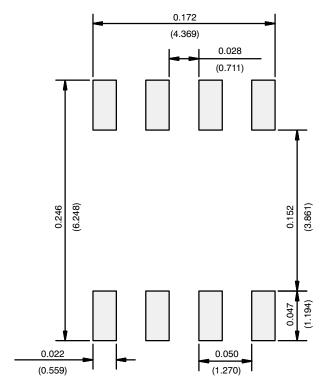
	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06						

DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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